

<b>Notice of References Cited</b>	Application/Control No. 10/566,435		Applicant(s)/Patent Under Reexamination SHIROKURA ET AL.	
	Examiner Meless N. Zewdu		Art Unit 2617	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0110469 A1	06-2004	Judd et al.	455/015
*	B	US-2004/0101037 A1	05-2004	Meng, Teresa H.	375/220
*	C	US-2002/0172184 A1	11-2002	Kim et al.	370/344
*	D	US-7,103,669 B2	09-2006	Apostolopoulos, John G.	709/231
*	E	US-6,862,448 B1	03-2005	Bims, Harry	455/432.1
*	F	US-6,728,541 B2	04-2004	Ohkura et al.	455/445
*	G	US-2005/0058087 A1	03-2005	Beach et al.	370/257
*	H	US-7,280,842 B2	10-2007	Smolyar et al.	455/525
*	I	US-7,272,108 B2	09-2007	Li et al.	370/203
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.